Search Notes

Application/Control No.	Applicant(s)/Patent und r R xamination	
10/693,941	SUGAI ET AL.	
Examin r	Art Unit	
Dmitry Levitan	2616	

Dmitry Levitan

SEARCHED					
Class	Subclass	Date	Examiner		
370	389 392				
	395.1 422				
	422	-he	106		
	423	15/20	DL		
	428				
709	238				
"=					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
IEEE, EAST	5/30/06	DL		